

TOSHIBA CMOS Linear Integrated Circuit Silicon Monolithic

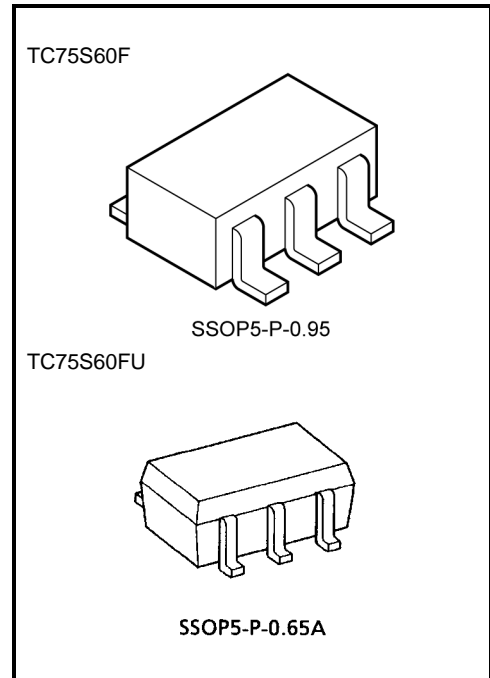
# TC75S60F, TC75S60FU

## Single Operational Amplifier

TC75S60F, TC75S60FU are CMOS operational amplifier with low supply voltage, low supply current.

### Features

- High slew rate: SR ( $V_{DD} = 3\text{ V}$ ) = 5.1 V/ $\mu\text{s}$  (typ.)
- The power supply operation range is:  
 $V_{DD} = \pm 0.9\sim 3.5\text{ V}$  or  $1.8\sim 7\text{ V}$
- Low supply current:  $I_{DD} (V_{DD} = 3\text{ V}) = 330\ \mu\text{A}$  (typ.)
- The internally phase compensated operational amplifier.
- Small package

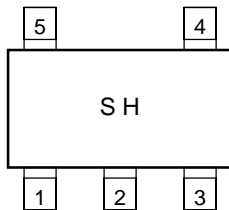


### Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

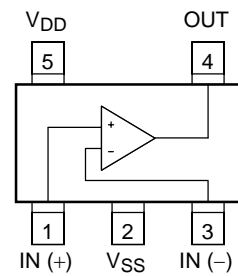
Characteristics	Symbol	Rating	Unit
Supply voltage	$V_{DD}, V_{SS}$	7	V
Differential input voltage	$DV_{IN}$	$\pm 7$	V
Input voltage	$V_{IN}$	$V_{DD}\sim V_{SS}$	V
Power dissipation	$P_D$	200	mW
Operating temperature	$T_{opr}$	-40~85	$^\circ\text{C}$
Storage temperature	$T_{stg}$	-55~125	$^\circ\text{C}$

Weight  
 SSOP5-P-0.95 : 0.014 g (typ.)  
 SSOP5-P-0.65A : 0.006 g (typ.)

## Marking (top view)



## Pin Connection (top view)



## Electrical Characteristics

### DC Characteristics ( $V_{DD} = 3.0\text{ V}$ , $V_{SS} = \text{GND}$ , $T_a = 25^\circ\text{C}$ )

Characteristics	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Input offset voltage	$V_{IO}$	1	$R_S = 1\text{ k}\Omega$	—	2	7	mV
Input offset current	$I_{IO}$	—	—	—	1	—	pA
Input bias current	$I_I$	—	—	—	1	—	pA
Common mode input voltage	$CMV_{IN}$	2	—	0.0	—	2.1	V
Voltage gain (open loop)	$G_V$	—	—	60	70	—	dB
Maximum output voltage	$V_{OH}$	3	$R_L = 100\text{ k}\Omega$	2.9	—	—	V
	$V_{OL}$	4	$R_L = 100\text{ k}\Omega$	—	—	0.1	
Common mode rejection ratio	CMRR	2	$V_{IN} = 0.0\sim 2.1\text{ V}$	54	70	—	dB
Supply voltage rejection ratio	SVRR	1	$V_{DD} = 1.8\sim 7.0\text{ V}$	60	70	—	dB
Supply current	$I_{DD}$	5	—	—	330	500	$\mu\text{A}$
Source current	$I_{source}$	6	—	330	700	—	$\mu\text{A}$
Sink current	$I_{sink}$	7	—	600	1250	—	$\mu\text{A}$

### DC Characteristics ( $V_{DD} = 1.8\text{ V}$ , $V_{SS} = \text{GND}$ , $T_a = 25^\circ\text{C}$ )

Characteristics	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Input offset voltage	$V_{IO}$	1	$R_S = 10\text{ k}\Omega$	—	2	7	mV
Input offset current	$I_{IO}$	—	—	—	1	—	pA
Input bias current	$I_I$	—	—	—	1	—	pA
Common mode input voltage	$CMV_{IN}$	2	—	0.3	—	0.9	V
Voltage gain (open loop)	$G_V$	—	—	—	70	—	dB
maximum output voltage	$V_{OH}$	3	$R_L = 100\text{ k}\Omega$	1.7	—	—	V
	$V_{OL}$	4	$R_L = 100\text{ k}\Omega$	—	—	0.1	
Common mode rejection ratio	CMRR	2	$V_{IN} = 0.3\sim 0.9\text{ V}$	50	60	—	dB
Supply current	$I_{DD}$	5	—	—	300	450	$\mu\text{A}$
Source current	$I_{source}$	6	—	300	600	—	$\mu\text{A}$
Sink current	$I_{sink}$	7	—	550	1150	—	$\mu\text{A}$

## AC Characteristics ( $V_{DD} = 3.0\text{ V}$ , $V_{SS} = \text{GND}$ , $T_a = 25^\circ\text{C}$ )

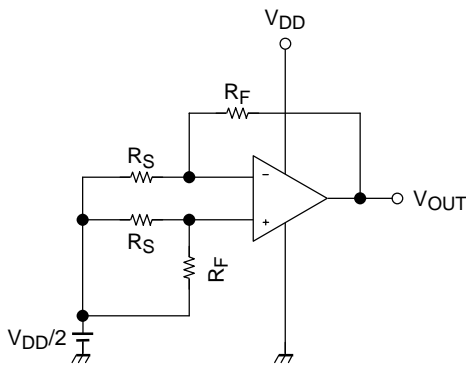
Characteristics	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Slew rate	SR	—	—	—	5.1	—	V/ $\mu\text{s}$
Unity gain cross frequency	$f_T$	—	—	—	3.7	—	MHz

## AC Characteristics ( $V_{DD} = 1.8\text{ V}$ , $V_{SS} = \text{GND}$ , $T_a = 25^\circ\text{C}$ )

Characteristics	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Slew rate	SR	—	—	—	4.0	—	V/ $\mu\text{s}$
Unity gain cross frequency	$f_T$	—	—	—	3.0	—	MHz

## Test Circuit

### 1. SVRR, $V_{IO}$



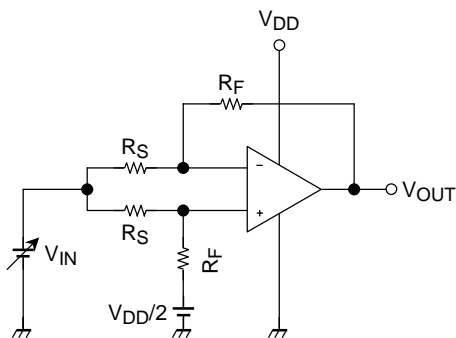
- SVRR  
 $V_{DD} = 1.8\text{ V}$ :  $V_{DD} = V_{DD1}$ ,  $V_{OUT} = V_{OUT1}$   
 $V_{DD} = 7.0\text{ V}$ :  $V_{DD} = V_{DD2}$ ,  $V_{OUT} = V_{OUT2}$   

$$SVRR = 20 \log \left( \left| \frac{V_{OUT1} - V_{OUT2}}{V_{DD1} - V_{DD2}} \right| \times \frac{R_S}{R_F + R_S} \right)$$

- $V_{IO}$   

$$V_{IO} = \left( V_{OUT} - \frac{V_{DD}}{2} \right) \times \frac{R_S}{R_F + R_S}$$

### 2. CMRR, $CMV_{IN}$

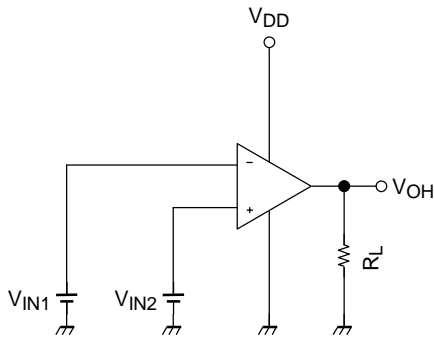


- CMRR  
 $V_{IN} = 0.0\text{ V}$ :  $V_{IN} = V_{IN1}$ ,  $V_{OUT} = V_{OUT1}$   
 $V_{IN} = 2.1\text{ V}$ :  $V_{IN} = V_{IN2}$ ,  $V_{OUT} = V_{OUT2}$   

$$CMRR = 20 \log \left( \left| \frac{V_{OUT1} - V_{OUT2}}{V_{IN1} - V_{IN2}} \right| \times \frac{R_S}{R_F + R_S} \right)$$

- $CMV_{IN}$

**3.  $V_{OH}$**

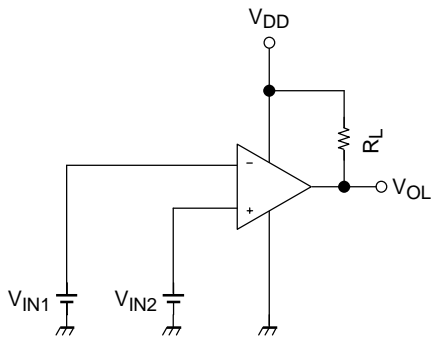


- $V_{OH}$   

$$V_{IN1} = \frac{V_{DD}}{2} - 0.05 \text{ V}$$

$$V_{IN2} = \frac{V_{DD}}{2} + 0.05 \text{ V}$$

**4.  $V_{OL}$**

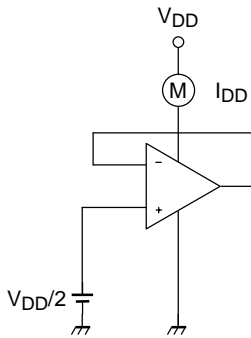


- $V_{OL}$   

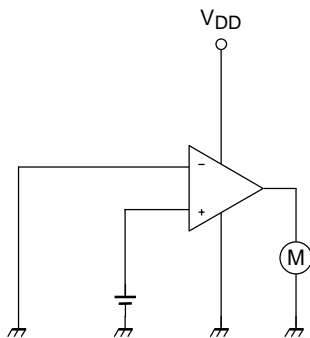
$$V_{IN1} = \frac{V_{DD}}{2} + 0.05 \text{ V}$$

$$V_{IN2} = \frac{V_{DD}}{2} - 0.05 \text{ V}$$

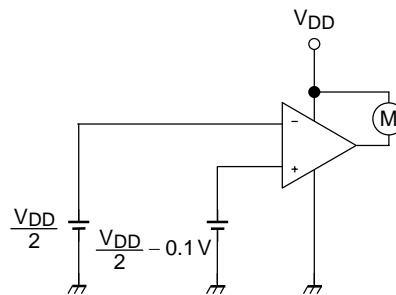
**5.  $I_{DD}$**

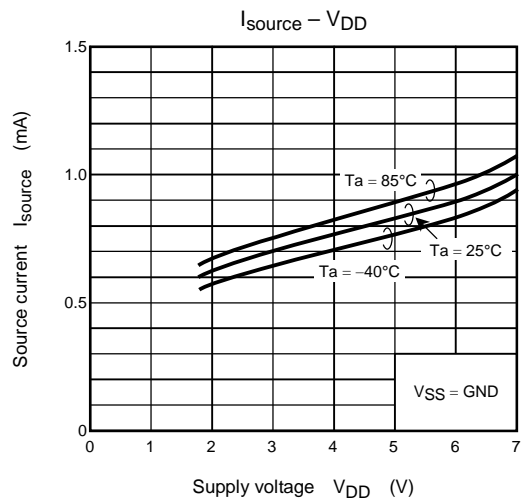
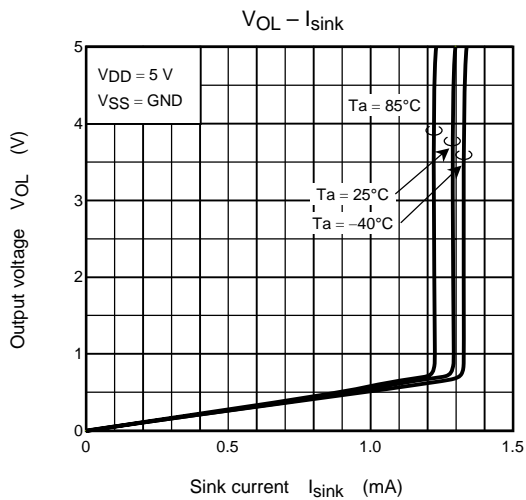
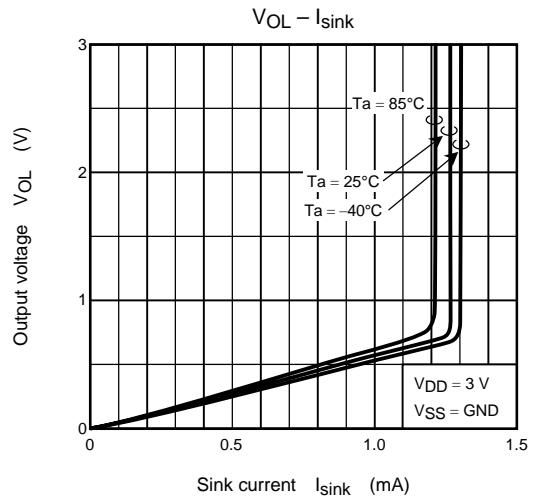
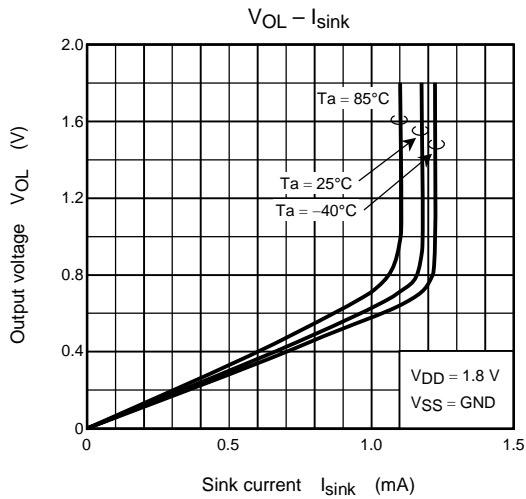
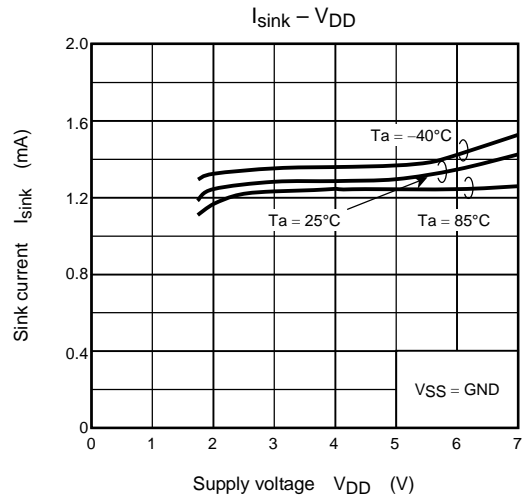
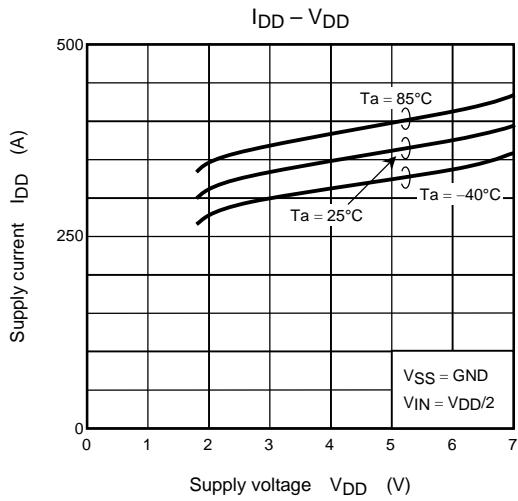


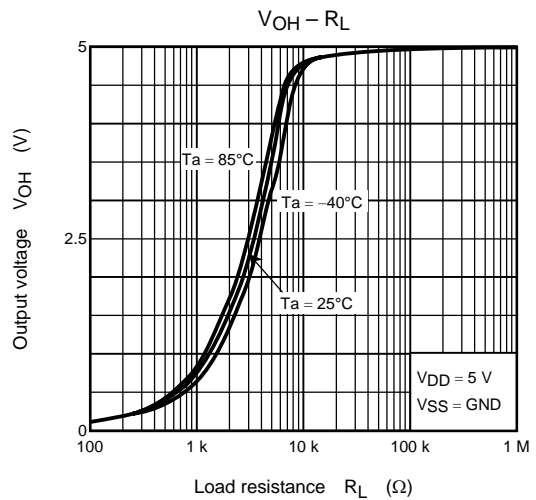
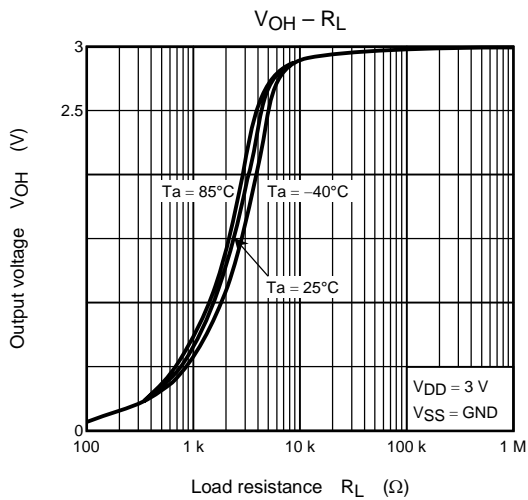
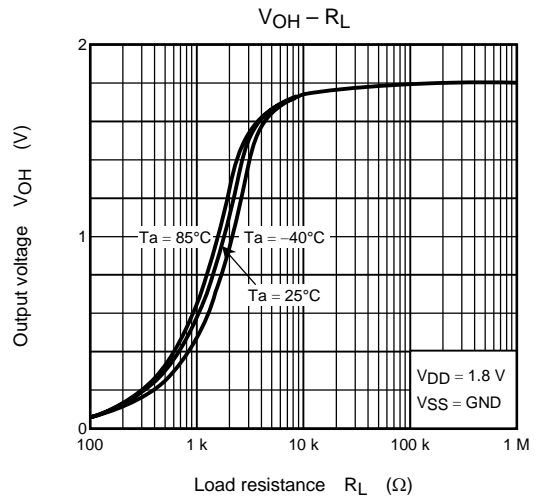
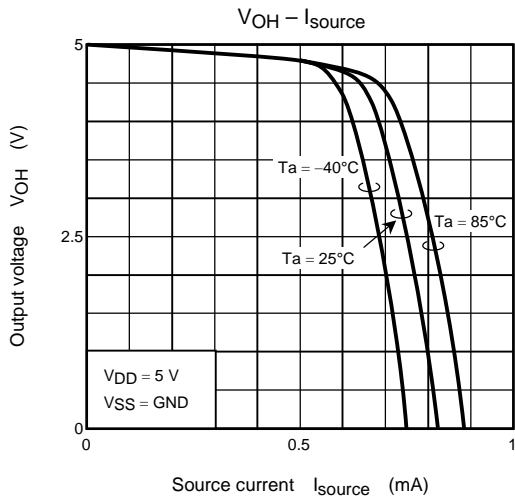
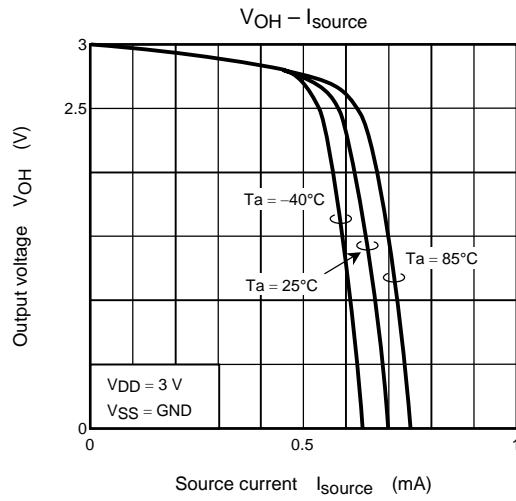
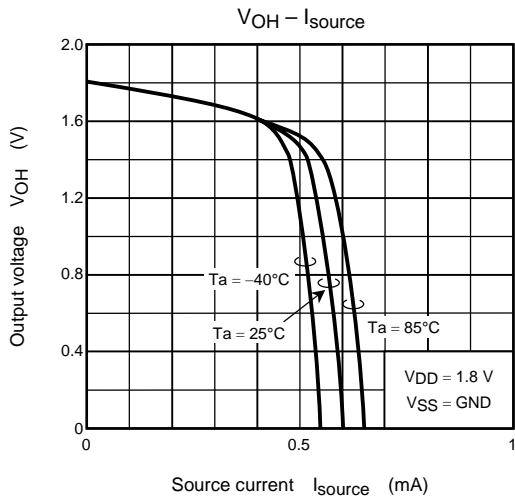
**6.  $I_{source}$**

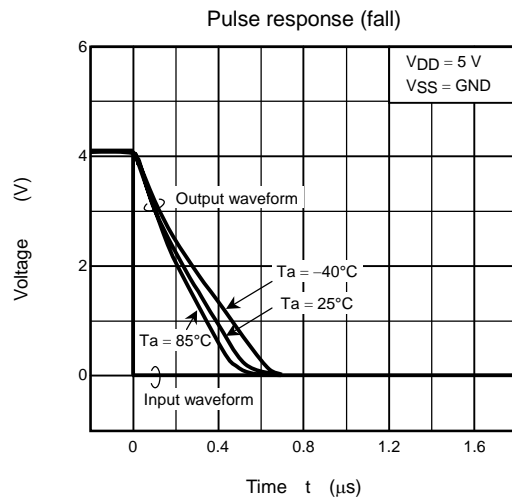
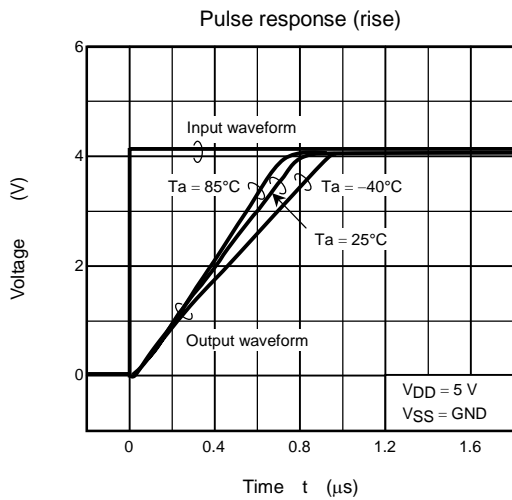
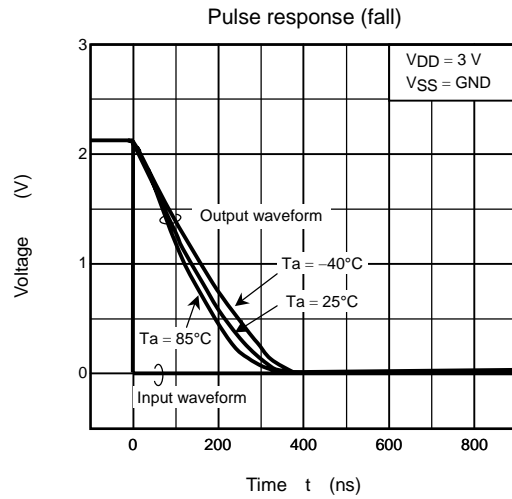
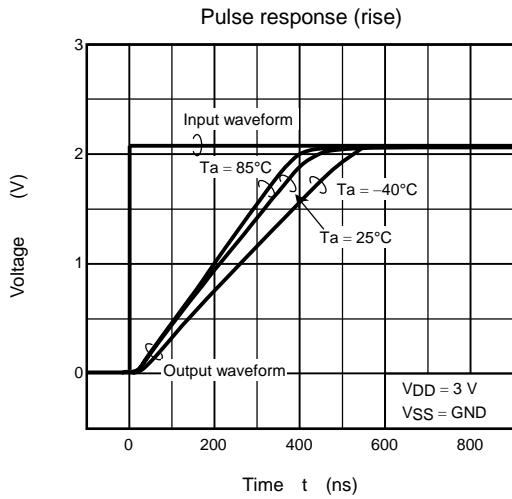
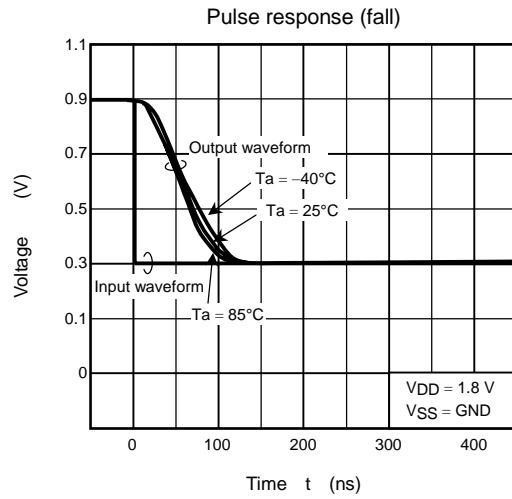
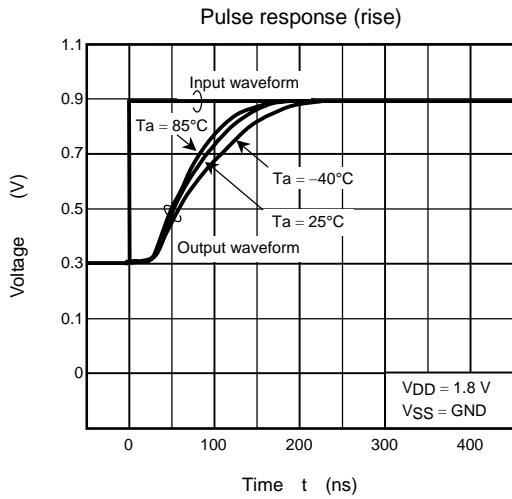


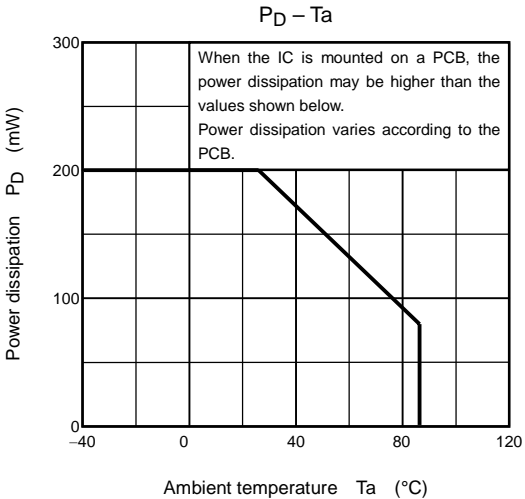
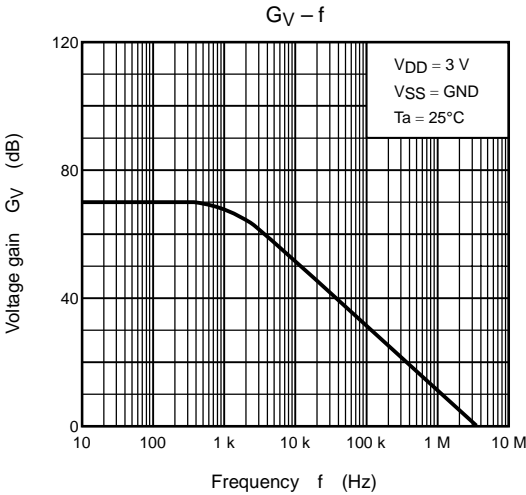
**7.  $I_{sink}$**









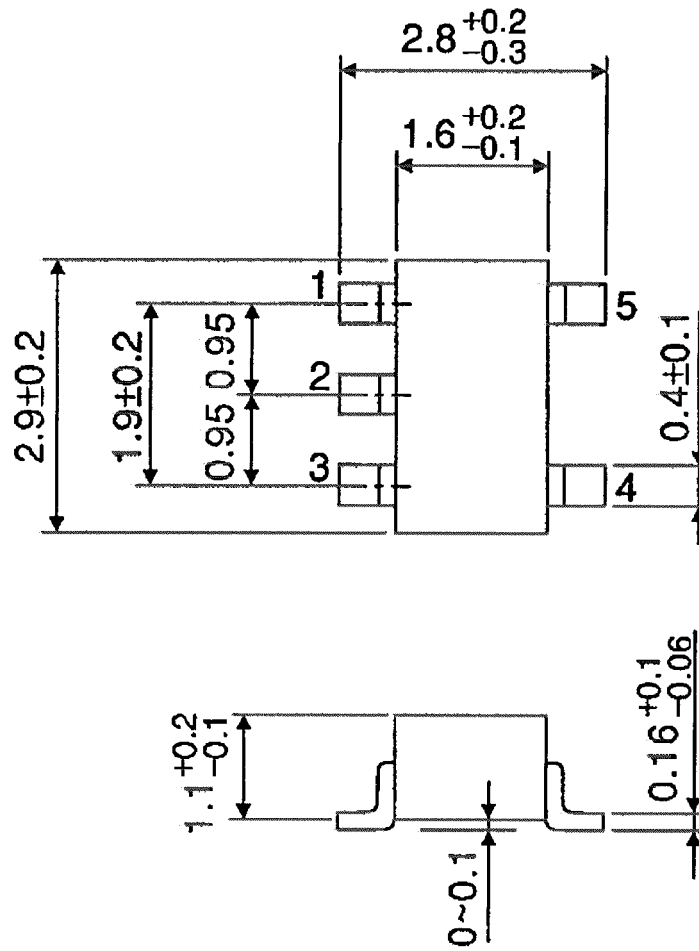




## Package Dimensions

SSOP5-P-0.95

Unit : mm

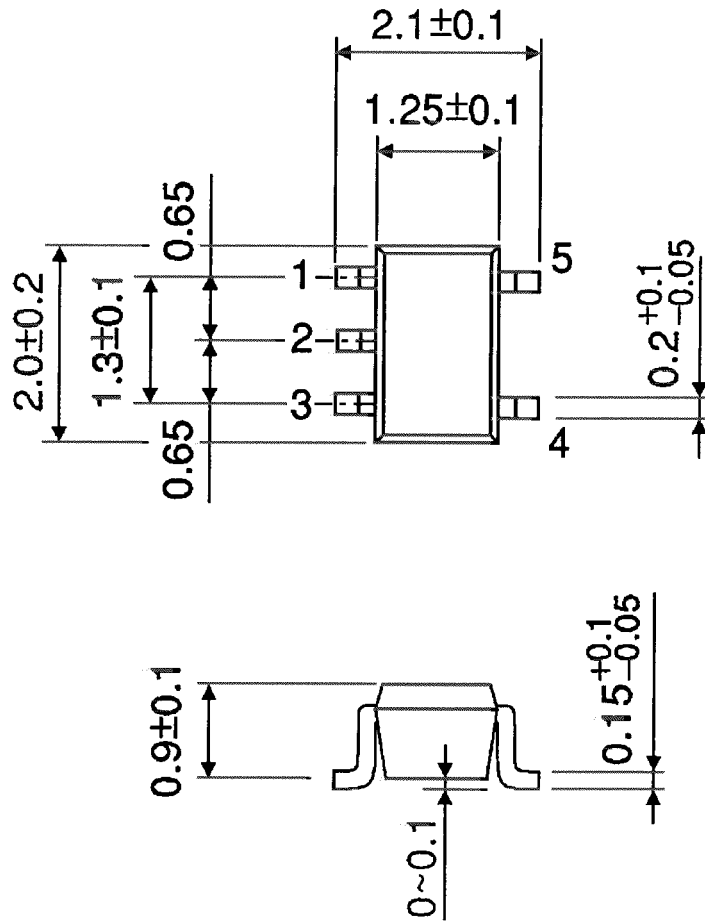


Weight: 0.014 g (typ.)

## Package Dimensions

SSOP5-P-0.65A

Unit : mm



Weight: 0.006 g (typ.)

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